

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/654,954	CHEN ET AL.
Examiner	Art Unit	
Meless N. Zewdu	2617	

Search Notes



Application/Control No.

10/654,954

Examiner

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**Applicant(s)/Patent under
Reexamination**

CHEN ET AL.

Art Unit

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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)